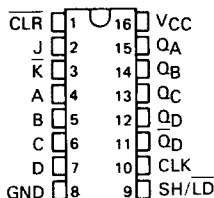


TYPES SN54195, SN54LS195A, SN54S195, SN74195, SN74LS195A, SN74S195 4-BIT PARALLEL-ACCESS SHIFT REGISTERS

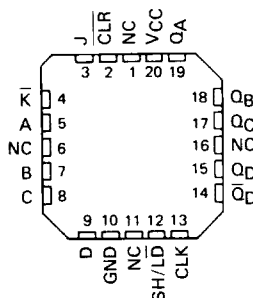
MARCH 1974—REVISED APRIL 1985

- Synchronous Parallel Load
- Positive-Edge-Triggered Clocking
- Parallel Inputs and Outputs from Each Flip-Flop
- Direct Overriding Clear
- J and K Inputs to First Stage
- Complementary Outputs from Last Stage
- For Use in High Performance:
Accumulators/Processors
Serial-to-Parallel, Parallel-to-Serial
Converters

SN54195, SN54LS195A, SN54S195 ... J OR W PACKAGE
SN74195 ... J OR N PACKAGE
SN74LS195A, SN74S195 ... D, J OR N PACKAGE
(TOP VIEW)



SN54LS195, SN54S195 ... FK PACKAGE
SN74LS195, SN74S195 ... FN PACKAGE
(TOP VIEW)



NC - No internal connection

description

These 4-bit registers feature parallel inputs, parallel outputs, J-K serial inputs, shift/load control input, and a direct overriding clear. All inputs are buffered to lower the input drive requirements. The registers have two modes of operation:

Parallel (broadside) load
Shift (in the direction Q_A toward Q_D)

Parallel loading is accomplished by applying the four bits of data and taking the shift/load control input low. The data is loaded into the associated flip-flop and appears at the outputs after the positive transition of the clock input. During loading, serial data flow is inhibited.

Shifting is accomplished synchronously when the shift/load control input is high. Serial data for this mode is entered at the J-K inputs. These inputs permit the first stage to perform as a J-K, D-, or T-type flip-flop as shown in the function table.

The high-performance 'S195, with a 105-megahertz typical maximum shift-frequency, is particularly attractive for very-high-speed data processing systems. In most cases existing systems can be upgraded merely by using this Schottky-clamped shift register.

FUNCTION TABLE

INPUTS					OUTPUTS				
CLEAR	SHIFT/ LOAD	CLOCK	SERIAL J K	PARALLEL A B C D	Q_A	Q_B	Q_C	Q_D	$\bar{Q}_D$
L	X	X	X X	X X X X	L	L	L	L	H
H	L	↑	X X	a b c d	a	b	c	d	$\bar{d}$
H	H	L	X X	X X X X	Q_{A0}	Q_{B0}	Q_{C0}	Q_{D0}	$\bar{Q}_{D0}$
H	H	↑	L H	X X X X	Q_{A0}	Q_{A0}	Q_{Bn}	Q_{Cn}	$\bar{Q}_{Cn}$
H	H	↑	L L	X X X X	H	Q_{An}	Q_{Bn}	Q_{Cn}	$\bar{Q}_{Cn}$
H	H	↑	H H	X X X X	L	Q_{An}	Q_{Bn}	Q_{Cn}	$\bar{Q}_{Cn}$
H	H	↑	H L	X X X X	$\bar{Q}_{An}$	Q_{An}	Q_{Bn}	Q_{Cn}	$\bar{Q}_{Cn}$

H = high level (steady state)

L = low level (steady state)

X = irrelevant (any input, including transitions)

↑ = transition from low to high level

a, b, c, d = the level of steady state input at A, B, C, or D, respectively

Q_{A0} , Q_{B0} , Q_{C0} , Q_{D0} = the level of Q_A , Q_B , Q_C , or Q_D , respectively, before the indicated steady-state input conditions were established

Q_{An} , Q_{Bn} , Q_{Cn} = the level of Q_A , Q_B , or Q_C , respectively, before the most-recent transition of the clock

PRODUCTION DATA

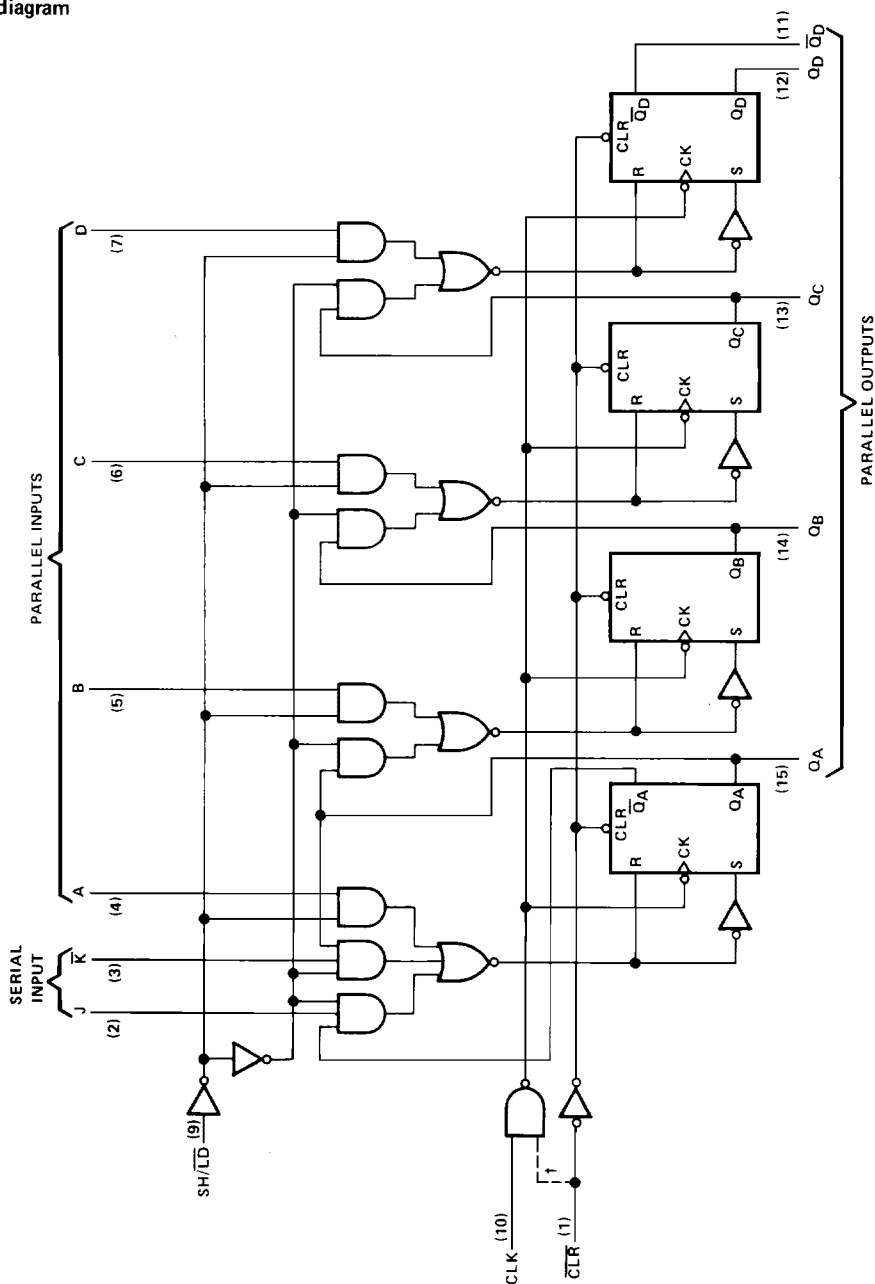
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TEXAS
INSTRUMENTS

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**TYPES SN54195, SN54LS195A, SN54S195,
SN74195, SN74LS195A, SN74S195
4-BIT PARALLEL-ACCESS SHIFT REGISTERS**

logic diagram



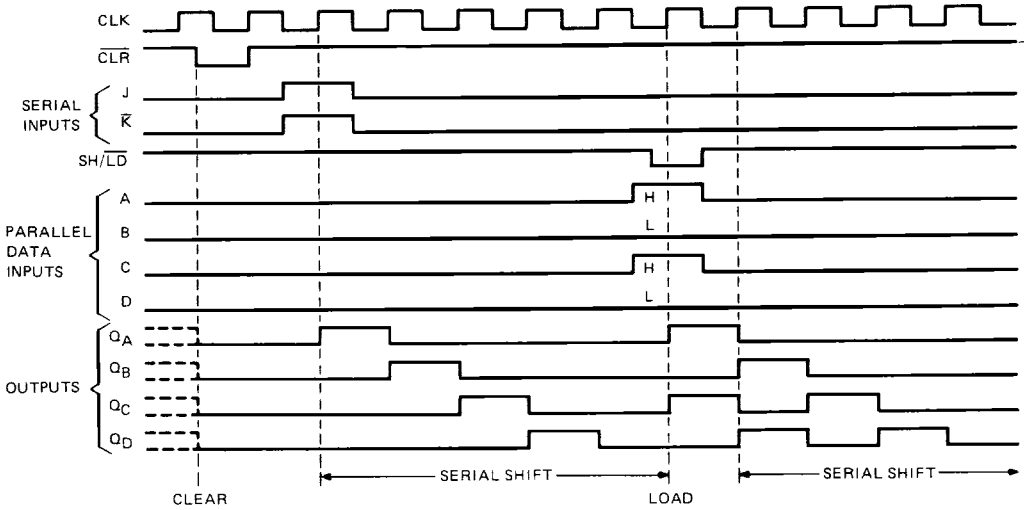
†This connection is made on '195 only.
Pin numbers shown on logic notation are for D, J or N packages.

3

TTL DEVICES

TYPES SN54195, SN54LS195A, SN54S195,
SN74195, SN74LS195A, SN74S195
4-BIT PARALLEL-ACCESS SHIFT REGISTERS

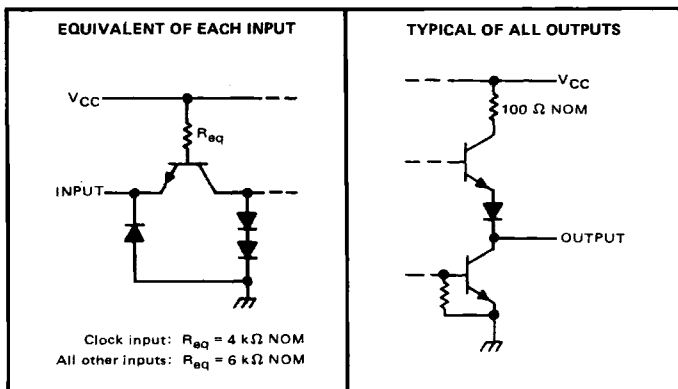
typical clear, shift, and load sequences



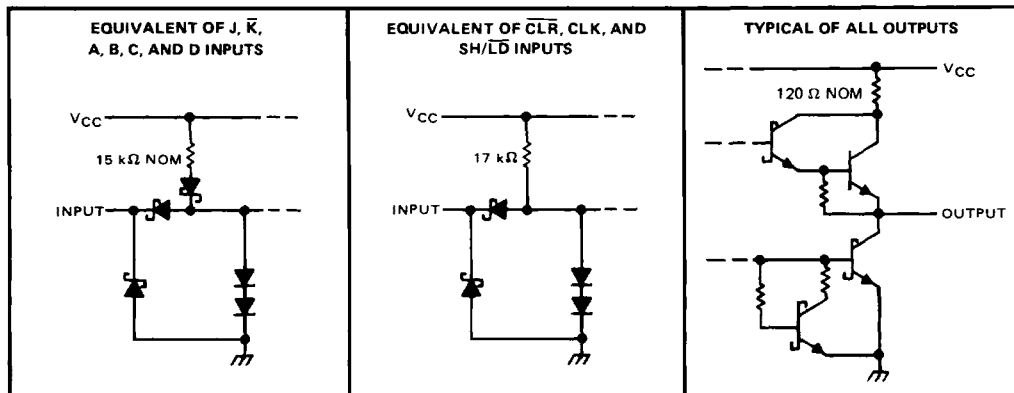
TYPES SN54195, SN54LS195A, SN54S195, SN74195, SN74LS195A, SN74S195 4-BIT PARALLEL-ACCESS SHIFT REGISTERS

schematics of inputs and outputs

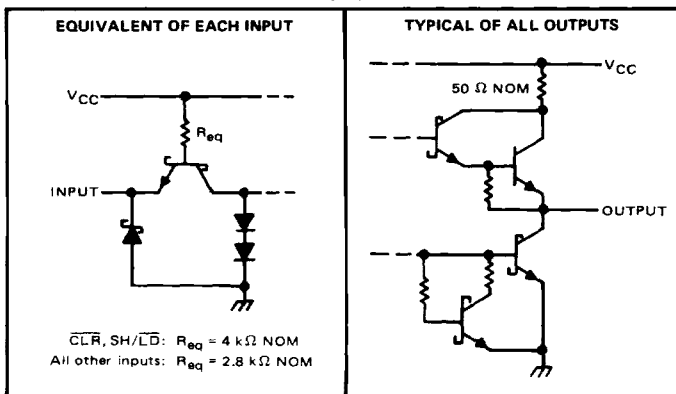
'195



'LS195A



'S195



3

TTL DEVICES

TYPES SN54195, SN74195

4-BIT PARALLEL-ACCESS SHIFT REGISTERS

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage	5.5 V
Operating free-air temperature range: SN54195	-55°C to 125°C
SN74195	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN54195			SN74195			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}		4.5	5	5.5	4.75	5	5.25	V
High-level output current, I_{OH}				-800			-800	μ A
Low-level output current, I_{OL}				16			16	mA
Clock frequency, f_{clock}			0	30		0	30	MHz
Width of clock input pulse, $t_{w(clock)}$			16			16		ns
Width of clear input pulse, $t_{w(clear)}$			12			12		ns
Setup time, t_{su} (see Figure 1)	Shift/load		25			25		ns
	Serial and parallel data		20			20		
	Clear inactive-state		25			25		
Shift/load release time, $t_{release}$ (see Figure 1)				20			10	ns
Serial and parallel data hold time, t_h (see Figure 1)			0			0		ns
Operating free-air temperature, T_A		-55		125	0		70	$^{\circ}$ C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	MIN	TYP‡	MAX	UNIT
V_{IH} High-level input voltage		2			V
V_{IL} Low-level input voltage				0.8	V
V_{IK} Input clamp voltage	$V_{CC} = \text{MIN}$, $I_I = -12 \text{ mA}$			-1.5	V
V_{OH} High-level output voltage	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OH} = -800 \mu\text{A}$	2.4	3.4		V
V_{OL} Low-level output voltage	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OL} = 16 \text{ mA}$		0.2	0.4	V
I_I Input current at maximum input voltage	$V_{CC} = \text{MAX}$, $V_I = 5.5 \text{ V}$			1	mA
I_{IH} High-level input current	$V_{CC} = \text{MAX}$, $V_I = 2.4 \text{ V}$			40	μ A
I_{IL} Low-level input current	$V_{CC} = \text{MAX}$, $V_I = 0.4 \text{ V}$			1.6	mA
I_{OS} Short-circuit output current§	$V_{CC} = \text{MAX}$	SN54195	-20	-57	mA
		SN74195	-18	-57	mA
I_{CC} Supply current	$V_{CC} = \text{MAX}$, See Note 2		39	63	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ \text{C}$.

§ Not more than one output should be shorted at a time.

NOTE 2: With all outputs open, shift/load grounded, and 4.5 V applied to the J, K, and data inputs, I_{CC} is measured by applying a momentary ground, followed by 4.5 V, to clear and then applying a momentary ground, followed by 4.5 V, to clock.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ \text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{max} Maximum clock frequency	$C_L = 15 \text{ pF}$, $R_L = 400 \Omega$, See Figure 1	30	39		MHz
t_{PHL} Propagation delay time, high-to-low-level output from clear			19	30	ns
t_{PLH} Propagation delay time, low-to-high-level output from clock			14	22	ns
t_{PHL} Propagation delay time, high-to-low-level output from clock			17	26	ns

TYPES SN54LS195A, SN74LS195A

4-BIT PARALLEL-ACCESS SHIFT REGISTERS

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage	7 V
Operating free-air temperature range: SN54LS195A	-55°C to 125°C
SN74LS195A	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

			SN54LS195A			SN74LS195A			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V _{CC}			4.5	5	5.5	4.75	5	5.25	V
High-level output current, I _{OH}			-400			-400			μA
Low-level output current, I _{OL}			4			8			mA
Clock frequency, f _{clock}			0	30		0	30		MHz
Width of clock or clear pulse, t _w (clock)			16			16			ns
Width of clear input pulse, t _w (clear)			12			12			ns
Setup time, t _{su} (see Figure 1)	Shift/load		25			25			ns
	Serial and parallel data		15			15			
	Clear inactive-state		25			25			
Shift/load release time, t _{release} (see Figure 1)			20			20			ns
Serial and parallel data hold time, t _h (see Figure 1)			0			0			ns
Operating free-air temperature, T _A			-55 125			0 70			°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	SN54LS195A			SN74LS195A			UNIT
		MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IH} High-level input voltage		2			2			V
V_{IL} Low-level input voltage				0.7			0.8	V
V_{IK} Input clamp voltage	$V_{CC} = \text{MIN}$, $I_I = -18 \text{ mA}$			-1.5			-1.5	V
V_{OH} High-level output voltage	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $V_{IL} = V_{IL} \text{ max}$, $I_{OH} = -400 \mu\text{A}$	2.5	3.4		2.7	3.4		V
V_{OL} Low-level output voltage	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $V_{IL} = V_{IL} \text{ max}$		0.25	0.4		0.25	0.4	V
	$I_{OL} = 4 \text{ mA}$					0.35	0.5	
	$I_{OL} = 8 \text{ mA}$							
I_I Input current at maximum input voltage	$V_{CC} = \text{MAX}$, $V_I = 7 \text{ V}$			0.1			0.1	mA
I_{IH} High-level input current	$V_{CC} = \text{MAX}$, $V_I = 2.7 \text{ V}$			20			20	μ A
I_{IL} Low-level input current	$V_{CC} = \text{MAX}$, $V_I = 0.4 \text{ V}$			-0.4			-0.4	mA
I_{OS} Short-circuit output current§	$V_{CC} = \text{MAX}$	-20	-100		-20	-100		mA
I_{CC} Supply current	$V_{CC} = \text{MAX}$, See Note 2		14	21		14	21	mA

†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

§Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

NOTE 2: With all outputs open, shift/load grounded, and 4.5 V applied to the J, K, and data inputs, I_{CC} is measured by applying a momentary ground, followed by 4.5 V, to clear and then applying a momentary ground, followed by 4.5 V, to clock.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{max} Maximum clock frequency	$C_L = 15 \text{ pF}$	30	39		MHz
t_{PHL} Propagation delay time, high-to-low-level output from clear	$R_L = 2 \text{ k}\Omega$		19	30	ns
t_{PLH} Propagation delay time, low-to-high-level output from clock	See Figure 1		14	22	ns
t_{PHL} Propagation delay time, high-to-low-level output from clock			17	26	ns

TYPES SN54S195, SN74S195

4-BIT PARALLEL-ACCESS SHIFT REGISTERS

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage	5.5 V
Operating free-air temperature range: SN54S195	-55°C to 125°C
SN74S195	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN54S195			SN74S195			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}		4.5	5	5.5	4.75	5	5.25	V
High-level output current, I_{OH}		-1			-1			mA
Low-level output current, I_{OL}		20			20			mA
Clock frequency, f_{clock}		0	70		0	70		MHz
Width of clock input pulse, $t_w(\text{clock})$		7			7			ns
Width of clear input pulse, $t_w(\text{clear})$		12			12			ns
Setup time, t_{su} (see Figure 1)	Shift/load	11			11			ns
	Serial and parallel data	5			5			
	Clear inactive-state	9			9			
Shift/load release time, $t_{release}$ (see Figure 1)		6			6			ns
Serial and parallel data hold time, t_h (see Figure 1)		3			3			ns
Operating free-air temperature, T_A		-55	125		0	70		°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	MIN	TYP‡	MAX	UNIT
V_{IH} High-level input voltage		2			V
V_{IL} Low-level input voltage				0.8	V
V_{IK} Input clamp voltage	$V_{CC} = \text{MIN}, I_I = -18 \text{ mA}$			-1.2	V
V_{OH} High-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OH} = -1 \text{ mA}$	SN54S195	2.5	3.4	V
		SN74S195	2.7	3.4	
V_{OL} Low-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OL} = 20 \text{ mA}$			0.5	V
I_I Input current at maximum input voltage	$V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$			1	mA
I_{IH} High-level input current	$V_{CC} = \text{MAX}, V_I = 2.7 \text{ V}$			50	µA
I_{IL} Low-level input current	$V_{CC} = \text{MAX}, V_I = 0.5 \text{ V}$			-2	mA
I_{OS} Short-circuit output current§	$V_{CC} = \text{MAX}$		-40	-100	mA
I_{CC} Supply current	$V_{CC} = \text{MAX},$ See Note 2	SN54S195	70	99	mA
		SN74S195	70	109	

†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^\circ \text{C}$.

§Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

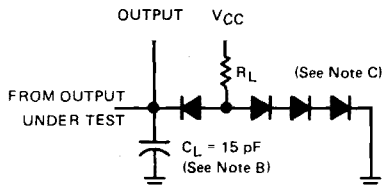
NOTE 2: With all outputs open, shift/load grounded, and 4.5 V applied to the J, K, and data inputs, I_{CC} is measured by applying a momentary ground, followed by 4.5 V, to clear, and then applying a momentary ground, followed by 4.5 V, to clock.

switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^\circ \text{C}$

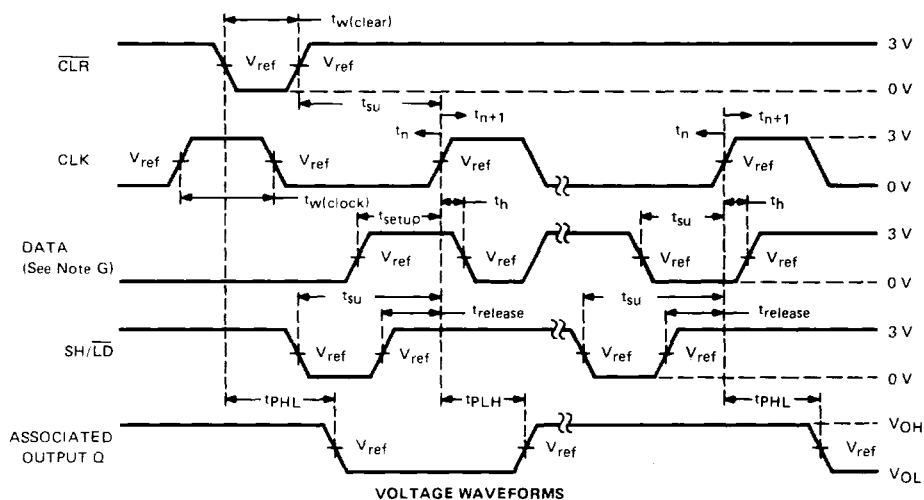
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{max} Maximum clock frequency	$C_L = 15 \text{ pF},$ $R_L = 280 \Omega,$ See Figure 1	70	105		MHz
t_{PHL} Propagation delay time, high-to-low-level output from clear			12.5	18.5	ns
t_{PLH} Propagation delay time, low-to-high-level output from clock			8	12	ns
t_{PHL} Propagation delay time, high-to-low-level output from clock			11	16.5	ns

**TYPES SN54195, SN54LS195A, SN54S195,
SN74195, SN74LS195A, SN74S195
4-BIT PARALLEL-ACCESS SHIFT REGISTERS**

PARAMETER MEASUREMENT INFORMATION



LOAD FOR OUTPUT UNDER TEST



- NOTES:**
- A. The clock pulse generator has the following characteristics: $Z_{out} \approx 50 \Omega$ and $PRR \leq 1 \text{ MHz}$. For '195, $t_r \leq 7 \text{ ns}$ and $t_f \leq 7 \text{ ns}$. For 'LS195A, $t_r \leq 15 \text{ ns}$ and $t_f \leq 6 \text{ ns}$. For 'S195, $t_r = 2.5 \text{ ns}$ and $t_f = 2.5 \text{ ns}$. When testing f_{max} , vary the clock PRR.
 - B. C_L includes probe and jig capacitance.
 - C. All diodes are 1N3064 or equivalent.
 - D. A clear pulse is applied prior to each test.
 - E. For '195 and 'S195, $V_{ref} = 1.5 \text{ V}$; for 'LS195A, $V_{ref} = 1.3 \text{ V}$.
 - F. Propagation delay times (t_{PLH} and t_{PHL}) are measured at t_{n+1} . Proper shifting of data is verified at t_{n+4} with a functional test.
 - G. J and K inputs are tested the same as data A, B, C, and D inputs except that shift/load input remains high.
 - H. t_n = bit time before clocking transition.
 t_{n+1} = bit time after one clocking transition.
 t_{n+4} = bit time after four clocking transitions.

FIGURE 1—SWITCHING TIMES